	Nation of Dafa-	ranga Citad	09/045,041	Applicant(s)	Fujisawa		
	Notice of Refer	ences cited	Examiner Group Art Ur Hugh Jones 2123				
		U.S	S. PATENT DOCUMENTS				
	DOCUMENT NO.	DATE	NAME		CLASS	SUBCLASS	
Α	6,031,979	2/1000	Hachiya		716	7	
В	5,809,284	9/1998	Fujisawa		703	14	
С							
D							
E							
F							
G							
н							
1							
J							
к							
L							
М							
		FORE	IGN PATENT DOCUMENTS				
	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS	
N							
0							
Р							
Q							
R							
s							
т							
		NO	N-PATENT DOCUMENTS				
	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)					DATE	
U	Chakrabarti et al.; "An improved hierarchical test geneation technique for combinational circuits with repetitive sub-circuits"; IEEE Proc. Test Symp.; pp. 237-243					11/1995	
v	Yokomizo et al.; "A new circuit recognition and reduction method for pattern based circuit simulation"; IEEE Custom Integrated Cir. Conf.; pp. 9.4/1-9.4/4					5/1990	
w							
x							